Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/683,635	RHAD ET AL.
Examiner	**Art Unit**
Mark K. Han	3767

SEARCHED

Class	Subclass	Date	Examiner
604	93.01	9/15/2006	mkh
	110		
	164.01		
	164.06		
	164.07		
	164.08		
	187 263		
	264 272		
128	919		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
inventor name search	3/20/2006	mkh
EAST text search	9/15/2006	mkh